

# TLE7276-2

5-V Low Dropout Voltage Regulator

Automotive Power



Never stop thinking



## 1 Overview

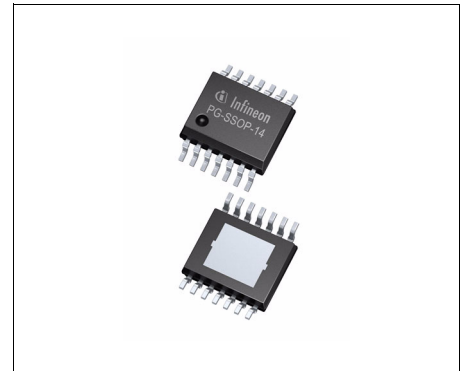
### Features

- Ultra Low Current Consumption 20  $\mu$ A
- Output Voltage 5 V  $\pm$ 2%
- Output Current up to 300 mA
- Enable Input
- Very Low Dropout Voltage
- Output Current Limitation
- Overtemperature Shutdown
- Wide Temperature Range From -40  $^{\circ}$ C up to 150  $^{\circ}$ C
- Green Product (RoHS compliant)
- AEC Qualified

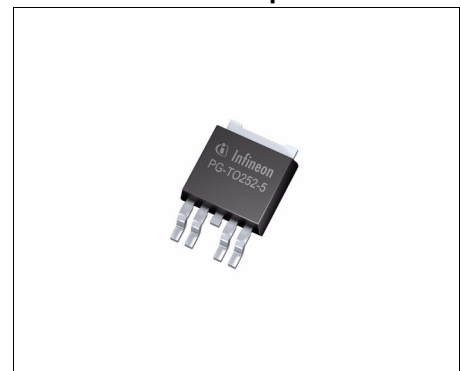
### Description

The TLE7276-2 is a monolithic integrated low dropout voltage regulator for load currents up to 300 mA. An input voltage up to 42 V is regulated to  $V_{Q,nom} = 5.0$  V with a precision of  $\pm$ 2%. The sophisticated design allows to achieve stable operation even with ceramic output capacitors down to 470 nF. The device is designed for the harsh environment of automotive applications. Therefore it is protected against overload, short circuit and overtemperature conditions by the implemented output current limitation and the overtemperature shutdown circuit. The TLE7276-2 can be also used in all other applications requiring a stabilized 5 V voltage.

Due to its ultra low quiescent current of typically 20  $\mu$ A the TLE7276-2 is dedicated for use in applications permanently connected to  $V_{BAT}$ . In addition the device can be switched off via the Enable input reducing the current consumption to typically 5  $\mu$ A. An integrated output sink current circuitry keeps the voltage at the Output pin Q below 5.5 V even in case of occurring reverse currents. Thus connected devices are protected from overvoltage damage. For applications requiring extremely low noise levels the Infineon voltage regulator family TLE 42XX and TLE 44XX is more suited than the TLE7276-2. A mV-range output noise on the TLE7276-2 caused by the charge pump operation is unavoidable due to the ultra low quiescent current concept.



**PG-SSOP-14 Exposed Pad**



**PG-TO252-5**

Type	Package	Marking
TLE7276-2E	PG-SSOP-14 Exposed Pad	7276-2E
TLE7276-2D	PG-TO252-5	7276-2D

## 2 Block Diagram

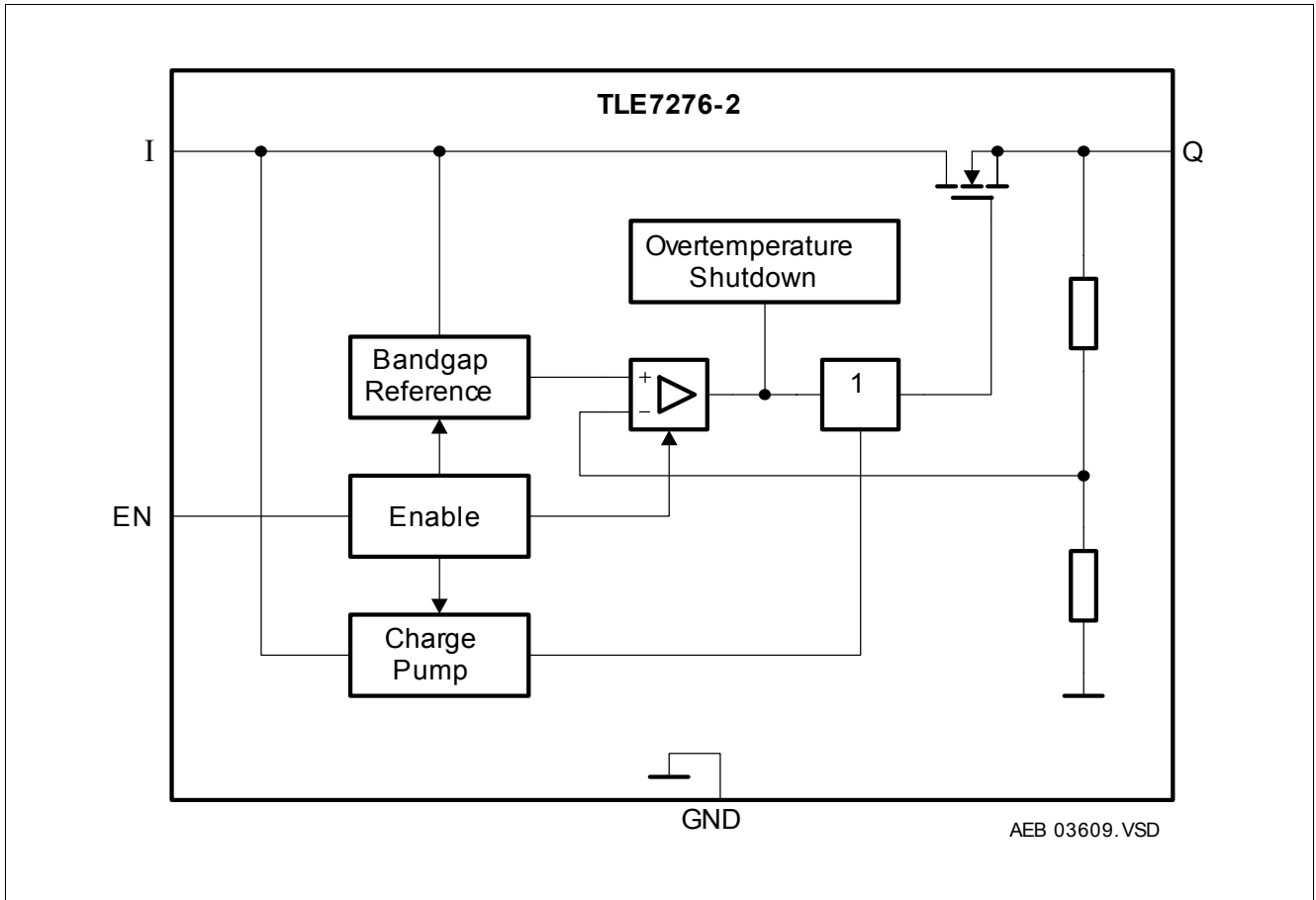


Figure 1 Block Diagram

### 3 Pin Configuration

#### 3.1 Pin Assignment PG-SSOP-14 Exposed Pad

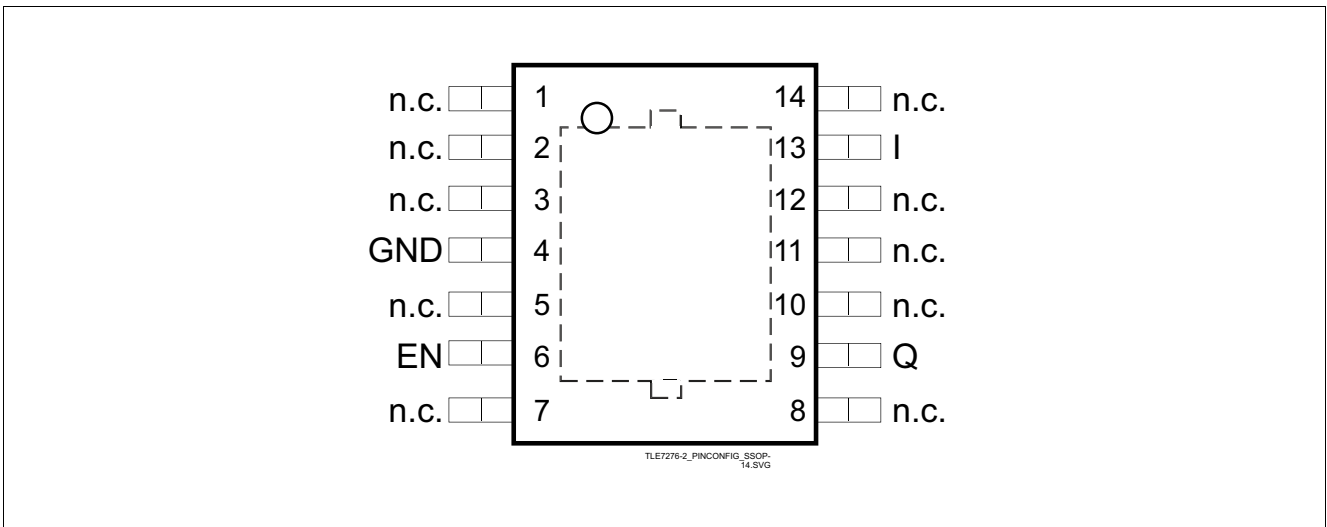


Figure 2 Pin Configuration (top view)

#### 3.2 Pin Definitions and Functions PG-SSOP-14 Exposed Pad

Pin No.	Symbol	Function
1,2,3,5,7	n.c.	<b>non connected</b> can be open or connected to GND
4	GND	<b>Ground</b>
6	EN	<b>Enable Input</b> high level input signal enables the IC; low level input signal disables the IC; integrated pull-down resistor
8,10,11,12,14	n.c.	<b>non connected</b> can be open or connected to GND
9	Q	<b>Output</b> block to ground with a capacitor close to the IC terminals, respecting the values given for its capacitance and ESR in <b>“Functional Range” on Page 6</b>
13	I	<b>Input</b> block to ground directly at the IC with a ceramic capacitor
Pad	–	<b>Exposed Pad</b> connect to GND and heatsink area

### 3.3 Pin Assignment PG-TO252-5

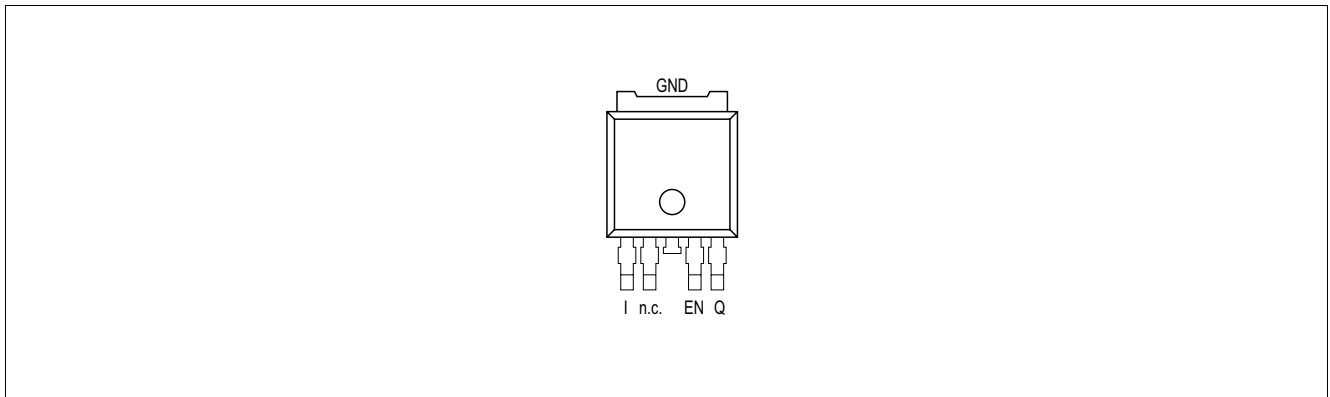


Figure 3 Pin Configuration (top view)

### 3.4 Pin Definitions and Functions PG-TO252-5

Pin No.	Symbol	Function
1	I	<b>Input</b> block to ground directly at the IC with a ceramic capacitor
2	n.c.	<b>non connected</b> can be open or connected to GND
3	GND	<b>Ground</b> internally connected to heat slug
4	EN	<b>Enable Input</b> high level input signal enables the IC; low level input signal disables the IC; integrated pull-down resistor
5	Q	<b>Output</b> block to ground with a capacitor close to the IC terminals, respecting the values given for its capacitance and ESR in <b>“Functional Range” on Page 6</b>
Heat Slug	–	<b>Heat Slug</b> internally connected to GND; connect to GND and heatsink area

## 4 General Product Characteristics

### 4.1 Absolute Maximum Ratings

#### Absolute Maximum Ratings<sup>1)</sup>

 $T_j = -40\text{ °C to }150\text{ °C}$ ; all voltages with respect to ground, (unless otherwise specified)

Pos.	Parameter	Symbol	Limit Values		Unit	Test Condition
			Min.	Max.		
<b>Input I</b>						
4.1.1	Voltage	$V_I$	-0.3	45	V	–
<b>Output Q</b>						
4.1.2	Voltage	$V_Q$	-0.3	6	V	–
4.1.3	Voltage	$V_Q$	-0.3	6.2	V	$t < 10\text{ s}^2)$
<b>Enable Input EN</b>						
4.1.4	Voltage	$V_{EN}$	-0.3	45	V	–
<b>Temperature</b>						
4.1.5	Junction temperature	$T_j$	-40	150	°C	–
4.1.6	Storage temperature	$T_{stg}$	-50	150	°C	–
<b>ESD Susceptibility</b>						
4.1.7	Human Body Model (HBM) <sup>3)</sup>	Voltage	-	3	kV	–
4.1.8	Charged Device Model (CDM) <sup>4)</sup>	Voltage	-	1.5	kV	–

1) not subject to production test, specified by design

2) exposure to these absolute maximum ratings for extended periods ( $t > 10\text{ s}$ ) may affect device reliability

3) ESD susceptibility Human Body Model “HBM” according to AEC-Q100-002 - JESD22-A114

4) ESD susceptibility Charged Device Model “CDM” according to ESDA STM5.3.1

*Note: Stresses above the ones listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.*

*Note: Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as “outside” normal operating range. Protection functions are not designed for continuous repetitive operation.*

### 4.2 Functional Range

Pos.	Parameter	Symbol	Limit Values		Unit	Remarks
			Min.	Max.		
4.2.1	Input voltage	$V_I$	5.5	42	V	–
4.2.2	Output Capacitor's	$C_Q$	470	–	nF	1)
4.2.3	Requirements	$ESR(C_Q)$	–	10	$\Omega$	2)
4.2.4	Junction temperature	$T_j$	-40	150	°C	–

1) the minimum output capacitance requirement is applicable for a worst case capacitance tolerance of 30%

2) relevant ESR value at  $f = 10\text{ kHz}$

*Note: Within the functional or operating range, the IC operates as described in the circuit description. The electrical characteristics are specified within the conditions given in the Electrical Characteristics table.*

### 4.3 Thermal Resistance

Note: This thermal data was generated in accordance with JEDEC JESD51 standards. For more information, go to [www.jedec.org](http://www.jedec.org).

Pos.	Parameter	Symbol	Limit Values			Unit	Conditions
			Min.	Typ.	Max.		
<b>TLE7276-2E (PG-SSOP-14 Exposed Pad)</b>							
4.3.1	Junction to Case <sup>1)</sup>	$R_{thJC}$	–	14	–	K/W	measured to exposed pad
4.3.2	Junction to Ambient <sup>1)</sup>	$R_{thJA}$	–	47	–	K/W	<sup>2)</sup>
4.3.3		$R_{thJA}$	–	141	–	K/W	footprint only <sup>3)</sup>
4.3.4		$R_{thJA}$	–	66	–	K/W	300 mm <sup>2</sup> heatsink area <sup>3)</sup>
4.3.5		$R_{thJA}$	–	56	–	K/W	600 mm <sup>2</sup> heatsink area <sup>3)</sup>
<b>TLE7276-2D (PG-TO252-5)</b>							
4.3.1	Junction to Case <sup>1)</sup>	$R_{thJC}$	–	6	–	K/W	measured to tab
4.3.2	Junction to Ambient <sup>1)</sup>	$R_{thJA}$	–	32	–	K/W	<sup>2)</sup>
4.3.3		$R_{thJA}$	–	115	–	K/W	footprint only <sup>3)</sup>
4.3.4		$R_{thJA}$	–	62	–	K/W	300 mm <sup>2</sup> heatsink area <sup>3)</sup>
4.3.5		$R_{thJA}$	–	47	–	K/W	600 mm <sup>2</sup> heatsink area <sup>3)</sup>

- 1) Not subject to production test, specified by design.
- 2) Specified  $R_{thJA}$  value is according to Jedec JESD51-2,-5,-7 at natural convection on FR4 2s2p board; The Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm<sup>3</sup> board with 2 inner copper layers (2 x 70µm Cu, 2 x 35µm Cu). Where applicable a thermal via array under the exposed pad contacted the first inner copper layer.
- 3) Specified  $R_{thJA}$  value is according to Jedec JESD 51-3 at natural convection on FR4 1s0p board; The Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm<sup>3</sup> board with 1 copper layer (1 x 70µm Cu).

## 5 Electrical Characteristics

### 5.1 Electrical Characteristics Voltage Regulator

#### Electrical Characteristics

 $V_I = 13.5 \text{ V}$ ;  $T_j = -40 \text{ }^\circ\text{C}$  to  $150 \text{ }^\circ\text{C}$ ; all voltages with respect to ground (unless otherwise specified)

Pos.	Parameter	Symbol	Limit Values			Unit	Measuring Condition
			Min.	Typ.	Max.		
<b>Output Q</b>							
5.1.1	Output Voltage	$V_Q$	4.9	5.0	5.1	V	$0.1 \text{ mA} < I_Q < 300 \text{ mA}$ $6 \text{ V} < V_I < 16 \text{ V}$
5.1.2	Output Voltage	$V_Q$	4.9	5.0	5.1	V	$0.1 \text{ mA} < I_Q < 100 \text{ mA}$ $6 \text{ V} < V_I < 40 \text{ V}$
5.1.3	Dropout Voltage	$V_{dr}$	–	250	500	mV	$I_Q = 200 \text{ mA}$ $V_{dr} = V_I - V_Q$ <sup>1)</sup>
5.1.4	Load Regulation	$\Delta V_{Q, lo}$	– 40	15	40	mV	$I_Q = 5 \text{ mA}$ to $250 \text{ mA}$
5.1.5	Line Regulation	$\Delta V_{Q, li}$	– 20	5	20	mV	$V_I = 10 \text{ V}$ to $32 \text{ V}$ $I_Q = 5 \text{ mA}$
5.1.6	Output Current Limitation	$I_Q$	301	–	–	mA	<sup>1)</sup>
5.1.7	Output Current Limitation	$I_Q$	–	–	800	mA	$V_Q = 0 \text{ V}$
5.1.8	Power Supply Ripple Rejection <sup>2)</sup>	$PSRR$	–	60	–	dB	$f_r = 100 \text{ Hz}$ ; $V_r = 0.5 \text{ Vpp}$
5.1.9	Temperature Output Voltage Drift	$\frac{dV_Q}{dT}$	–	0.5	–	mV/K	–

#### Current Consumption

5.1.10	Quiescent Current $I_q = I_I - I_Q$	$I_q$	–	20	30	$\mu\text{A}$	$I_Q = 0.1 \text{ mA}$ ; $V_{EN} = 5 \text{ V}$ $T_j = 25 \text{ }^\circ\text{C}$
5.1.11	Quiescent Current $I_q = I_I - I_Q$	$I_q$	–	–	40	$\mu\text{A}$	$I_Q = 0.1 \text{ mA}$ ; $V_{EN} = 5 \text{ V}$ $T_j \leq 80 \text{ }^\circ\text{C}$
5.1.12	Current Consumption, Regulator Disabled	$I_q$	–	5	9	$\mu\text{A}$	$V_{EN} = 0 \text{ V}$ ; $T_j < 80 \text{ }^\circ\text{C}$

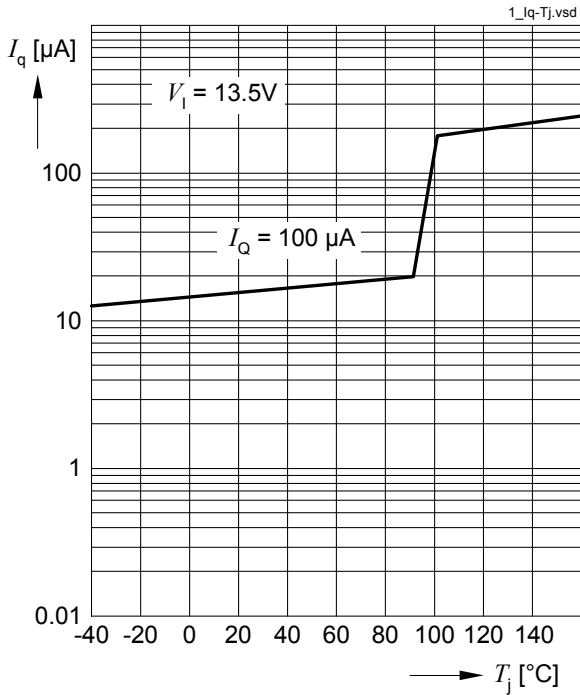
1) Measured when the output voltage  $V_Q$  has dropped 100 mV from the nominal value obtained at  $V_I = 13.5 \text{ V}$ .

2) not subject to production test, specified by design

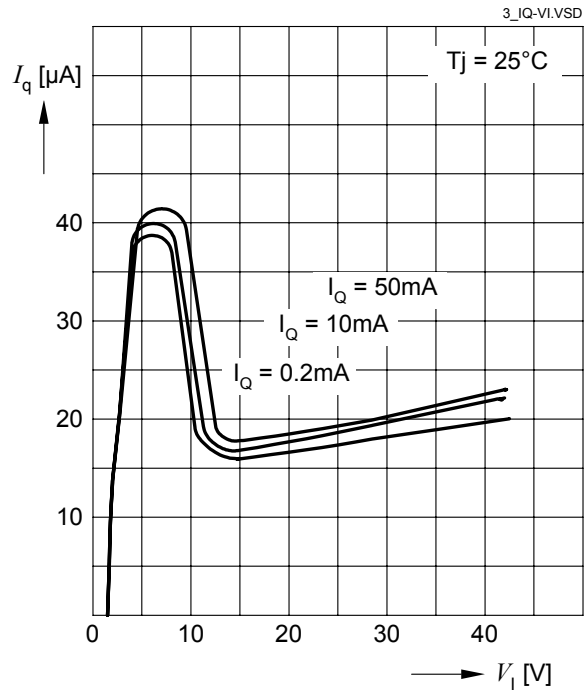


## 5.2 Typical Performance Characteristics Voltage Regulator

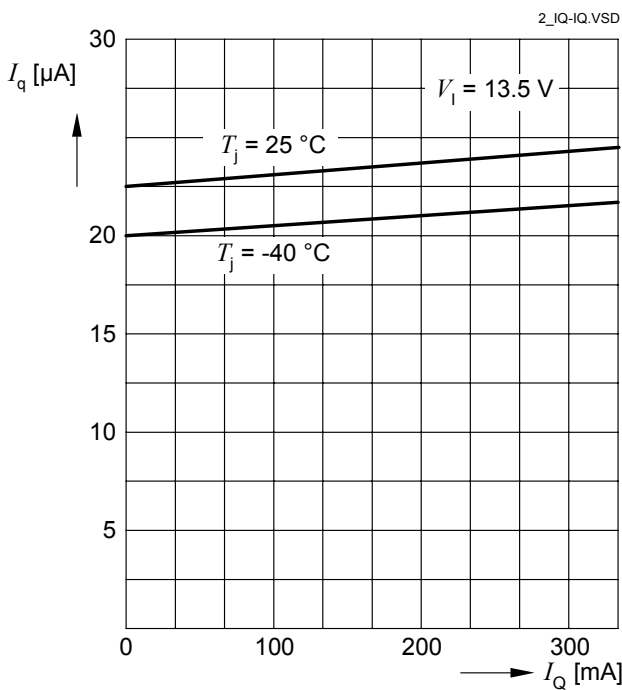
**Current Consumption  $I_q$  versus Junction Temperature  $T_j$**



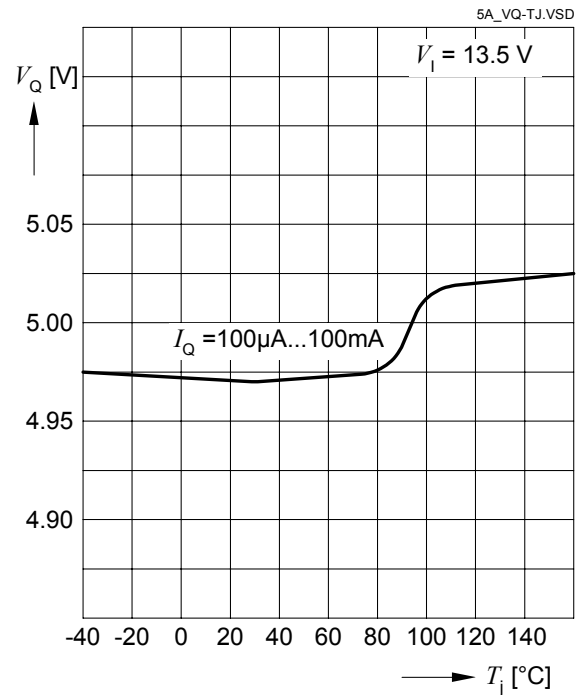
**Current Consumption  $I_q$  versus Input Voltage  $V_{Iq}$**



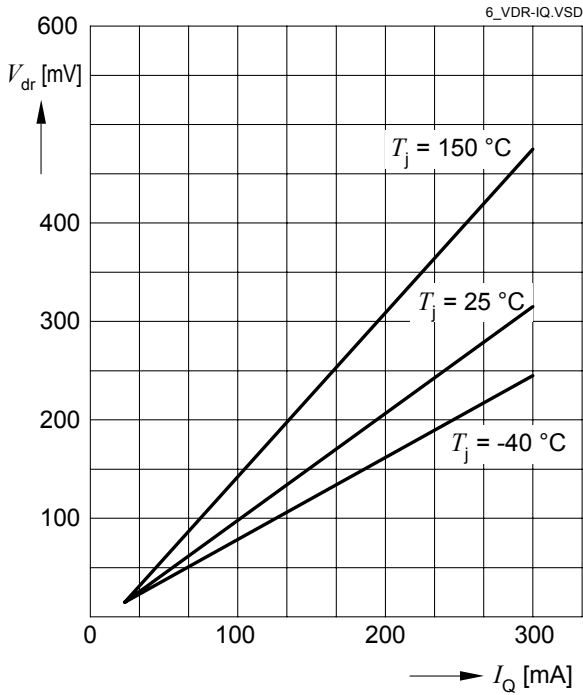
**Current Consumption  $I_q$  versus Output Current  $I_Q$**



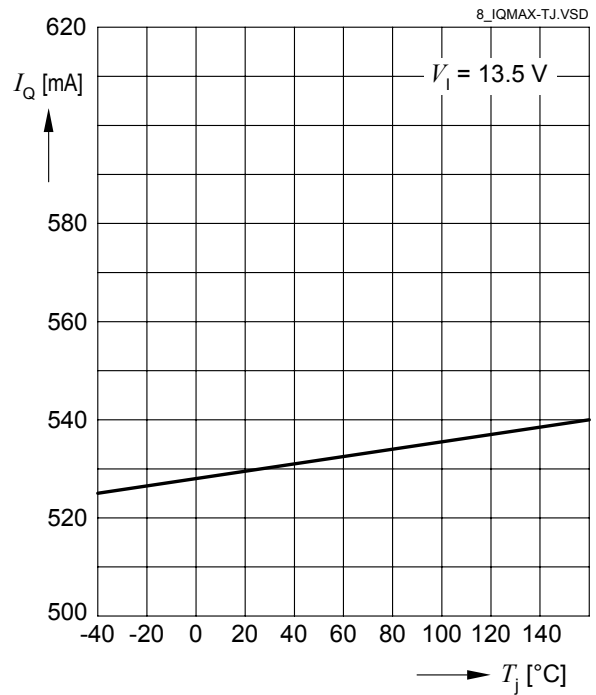
**Output Voltage  $V_Q$  versus Junction Temperature  $T_j$**



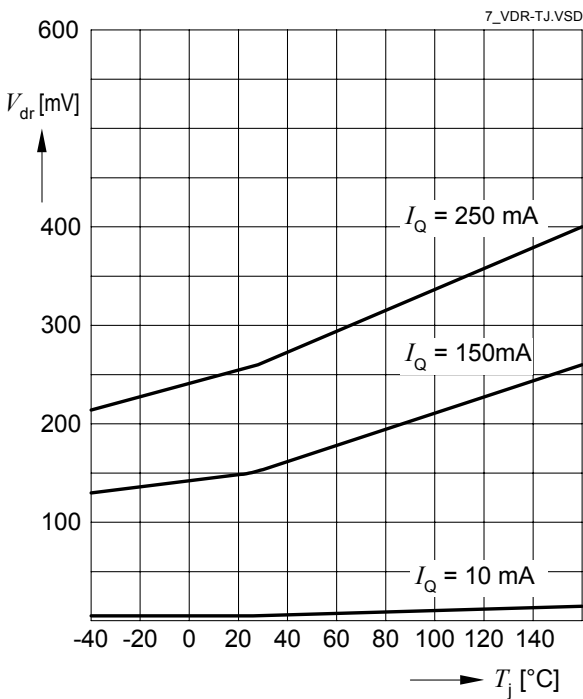
Dropout Voltage  $V_{dr}$  versus Output Current  $I_Q$



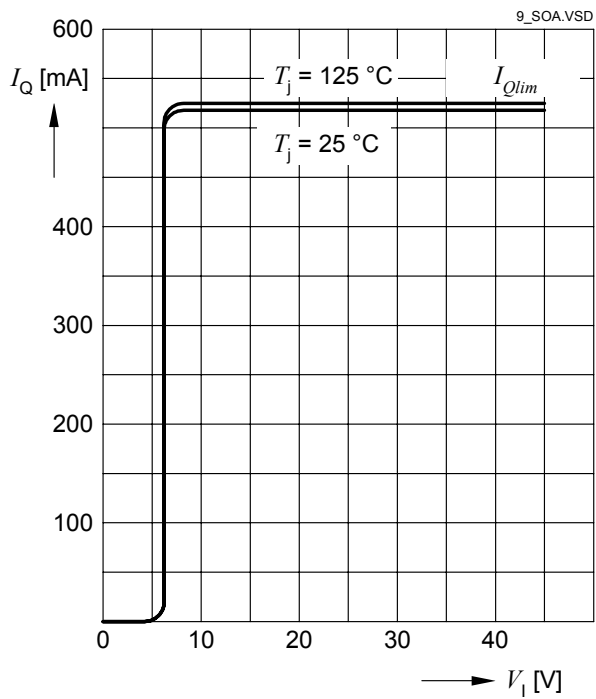
Maximum Output Current  $I_Q$  versus Junction Temperature  $T_j$



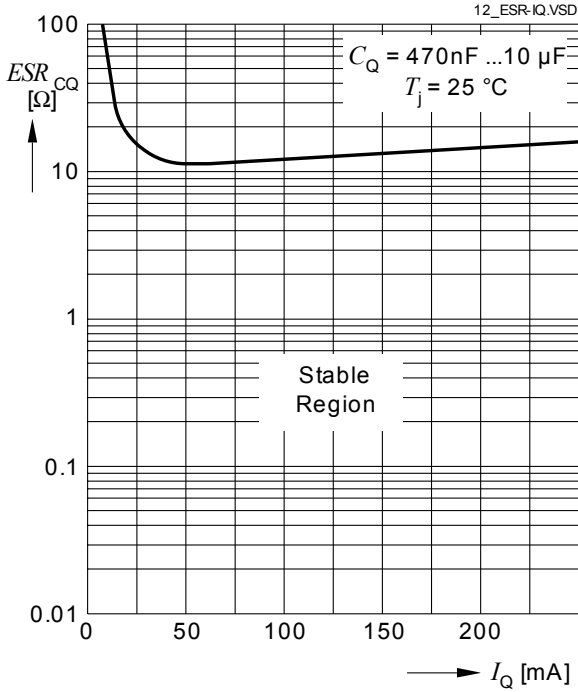
Dropout Voltage  $V_{dr}$  versus Junction Temperature



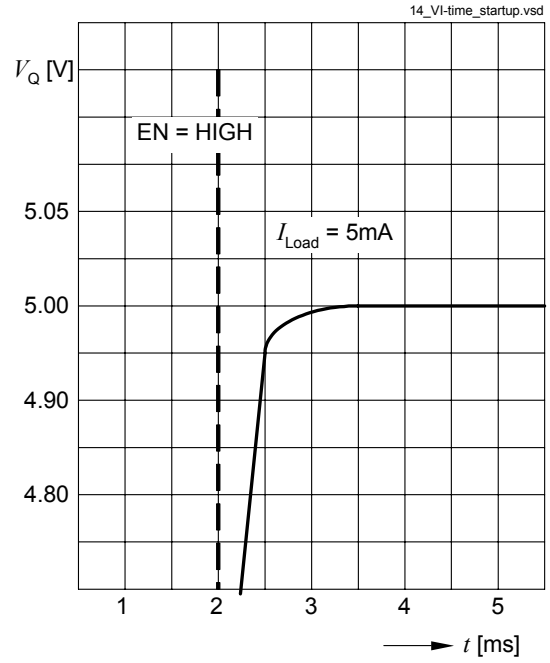
Maximum Output Current  $I_Q$  versus Input Voltage  $V_I$



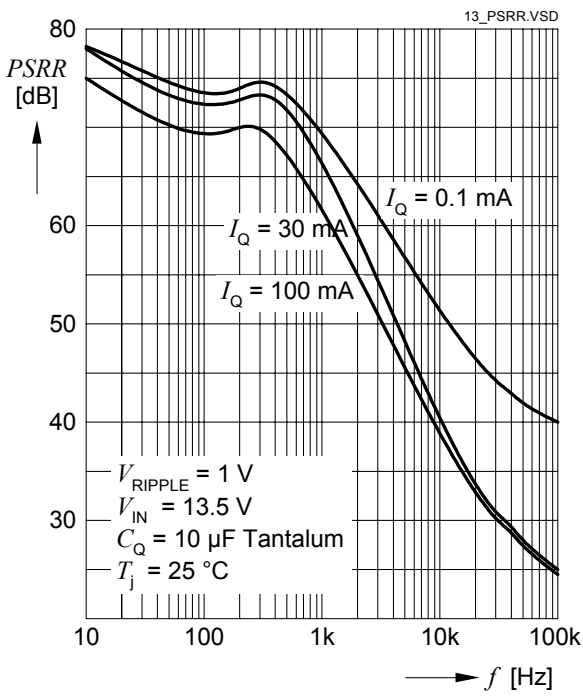
**Region of Stability**



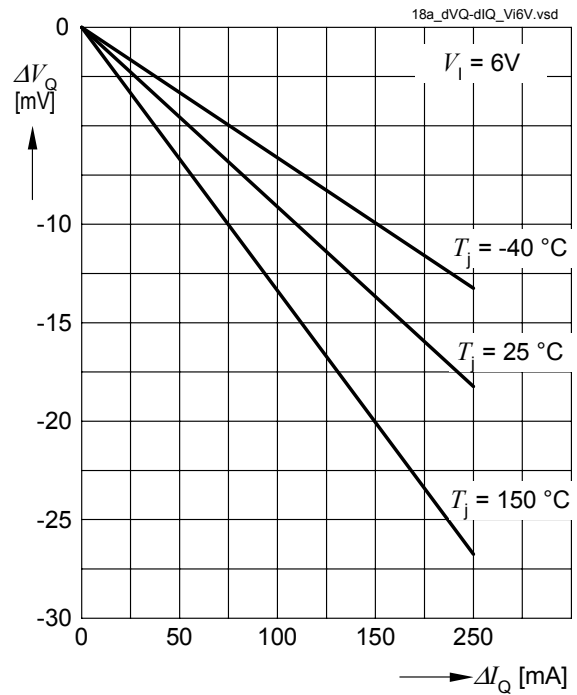
**Output Voltage  $V_Q$  Start-up behavior**



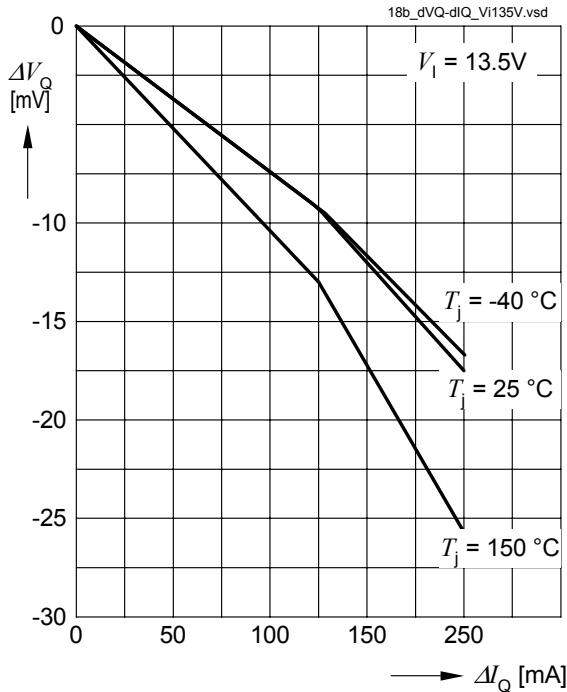
**Power Supply Ripple Rejection PSRR versus Frequency  $f$**



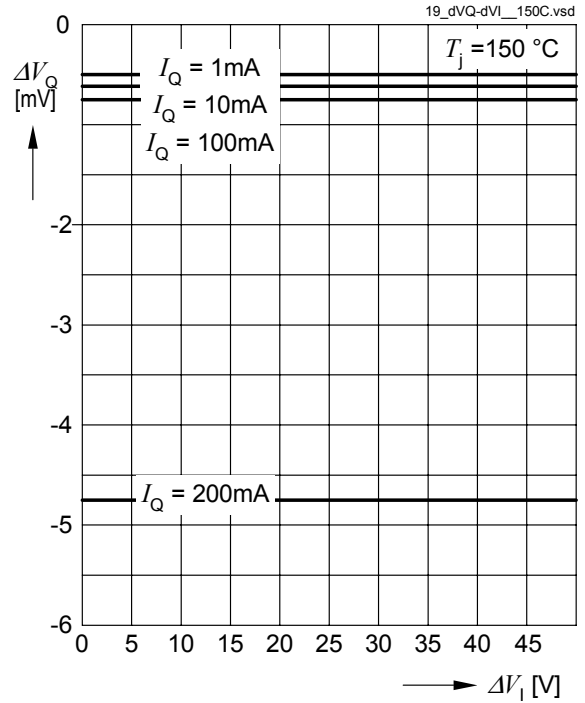
**Load Regulation  $\Delta V_Q$  versus Output Current Change  $\Delta I_Q$**



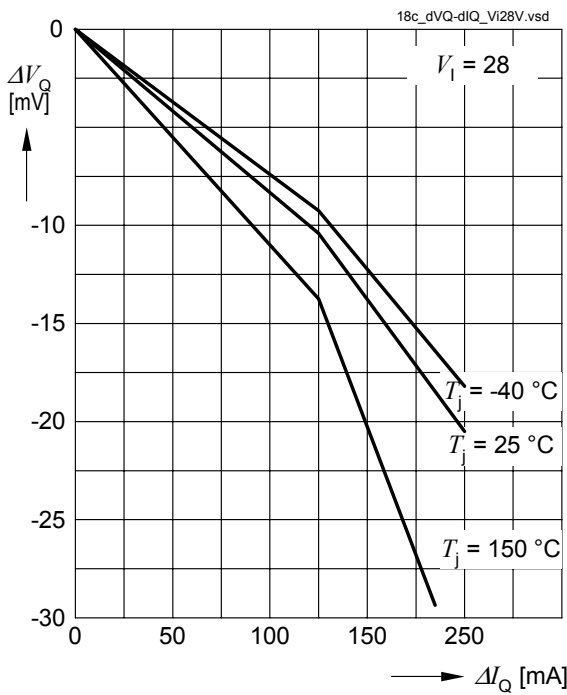
**Load Regulation  $\Delta V_Q$  versus Output Current Change  $dI_Q$**



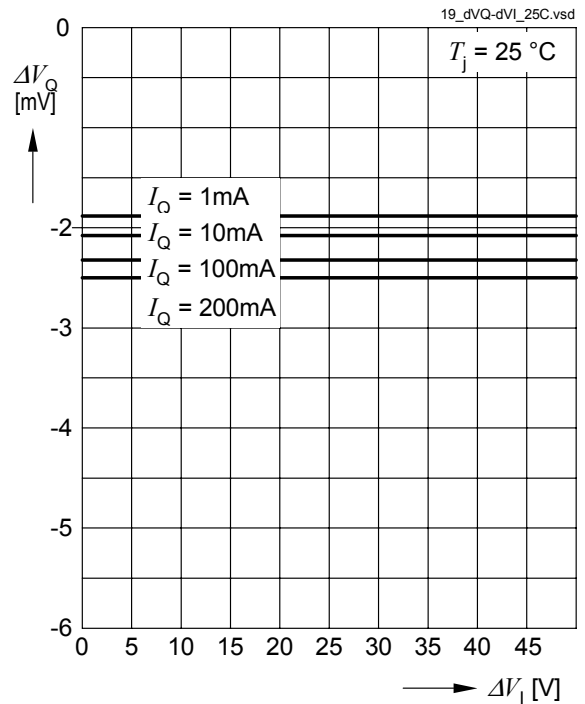
**Line Regulation  $\Delta V_Q$  versus Input Voltage Changed  $V_1$**



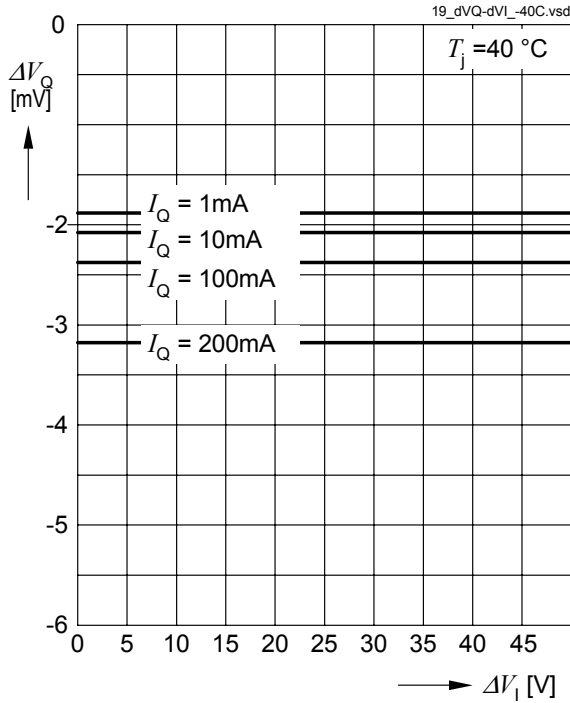
**Load Regulation  $\Delta V_Q$  versus Output Current Change  $\Delta I_Q$**



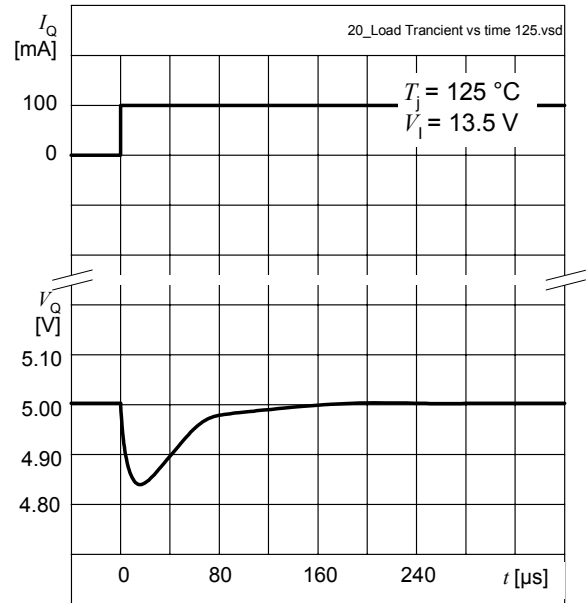
**Line Regulation  $\Delta V_Q$  versus Input Voltage Changed  $V_1$**



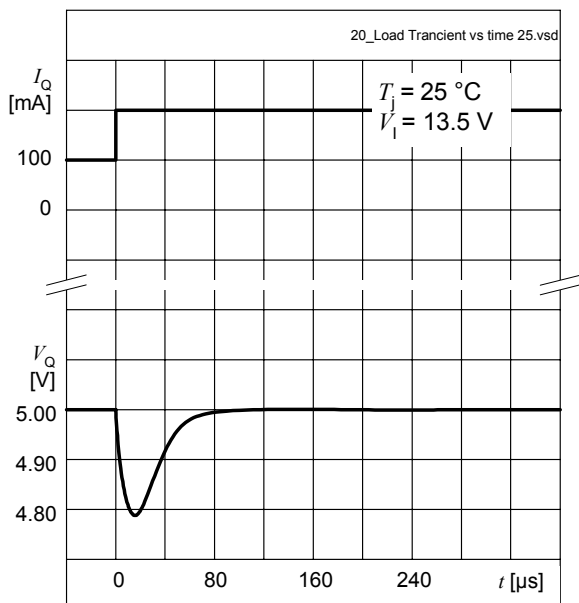
**Line Regulation  $\Delta V_Q$  versus Input Voltage Change  $V_I$**



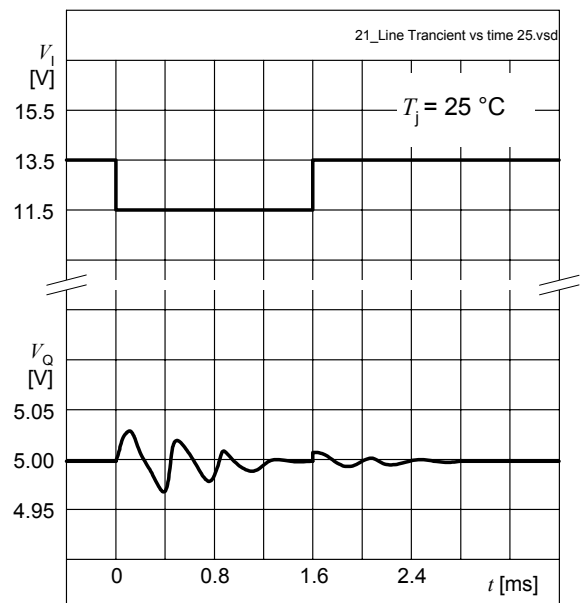
**Load Transient Response Peak Voltage  $\Delta V_Q$**



**Load Transient Response Peak Voltage  $\Delta V_Q$**

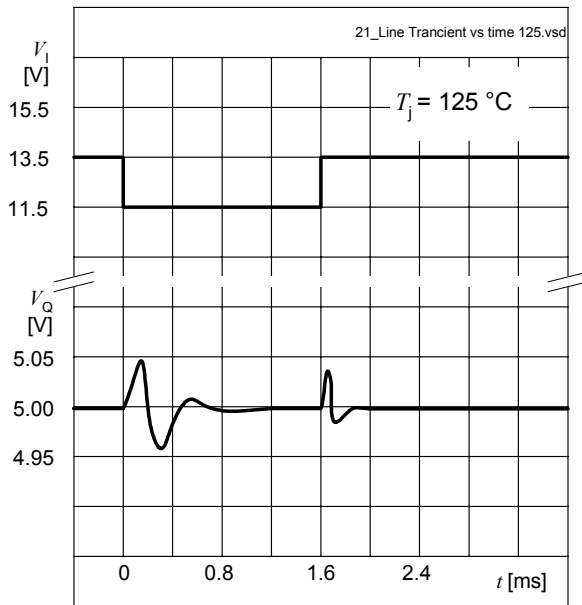


**Line Transient Response Peak Voltage  $\Delta V_Q$**



**Line Transient Response Peak Voltage  $\Delta V_Q$**

I



### 5.3 Electrical Characteristics Enable Function

The Enable Function allows disabling/enabling the regulator via the input pin EN. The regulator is turned on in case the pin EN is connected to a voltage higher than **VEN,H**. This can be e.g. the battery voltage, whereby no additional pull-up resistor is needed. The regulator can be turned off by connecting the pin EN to a voltage less than **VEN,L**, e.g. GND.

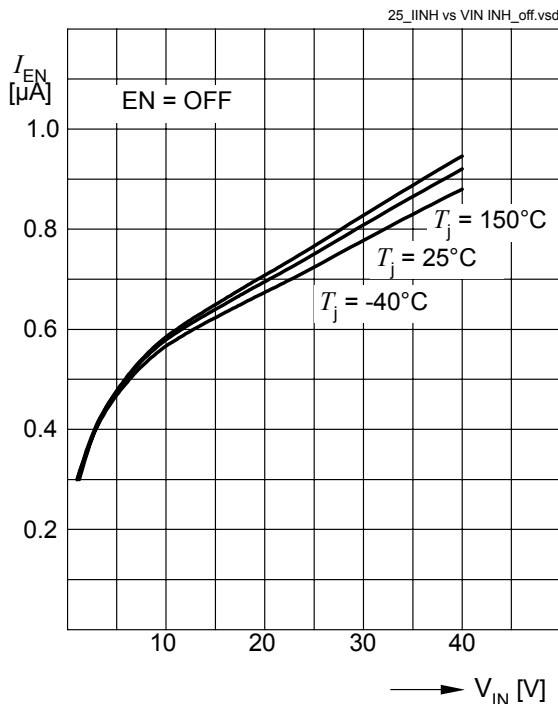
#### Electrical Characteristics Enable

$V_I=13.5\text{ V}$ ;  $T_j = -40\text{ }^\circ\text{C}$  to  $150\text{ }^\circ\text{C}$ ; all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

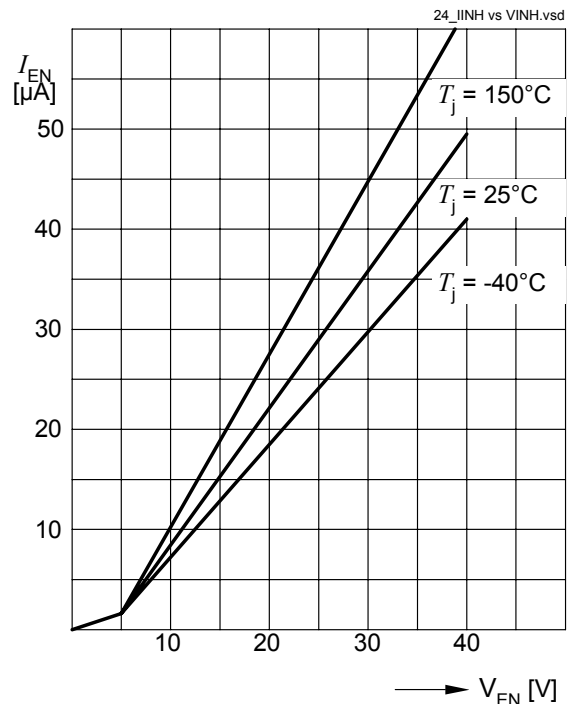
Pos.	Parameter	Symbol	Limit Values			Unit	Measuring Condition
			Min.	Typ.	Max.		
5.3.13	High Level Input Voltage	$V_{EN,H}$	3.1	–	–	V	$V_Q \geq 4.9\text{ V}$
5.3.14	Low Level Input Voltage	$V_{EN,L}$	–	–	0.8	V	$V_Q \leq 0.3\text{ V}$
5.3.15	High Level Input Current	$I_{EN,H}$	–	3	4	$\mu\text{A}$	$V_{EN} = 5\text{ V}$

### 5.4 Typical Performance Characteristics Enable Function

Enabled Input Current  $I_{EN}$  versus Input Voltage  $V_I$ , EN=Off



Enabled Input Current  $I_{EN}$  versus Enabled Input Voltage  $V_{EN}$



## 6 Package Outlines

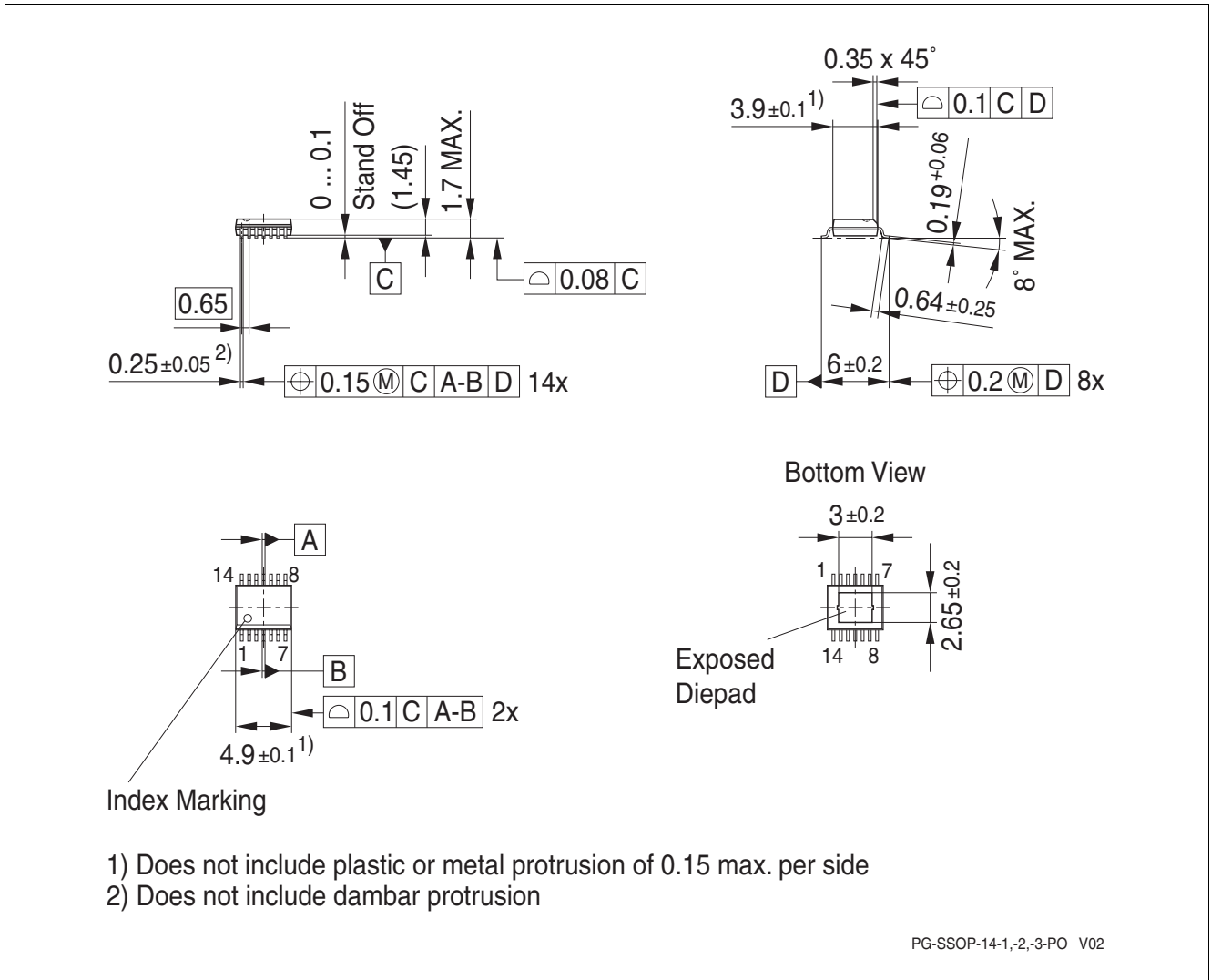


Figure 4 PG-SSOP-14 Exposed Pad



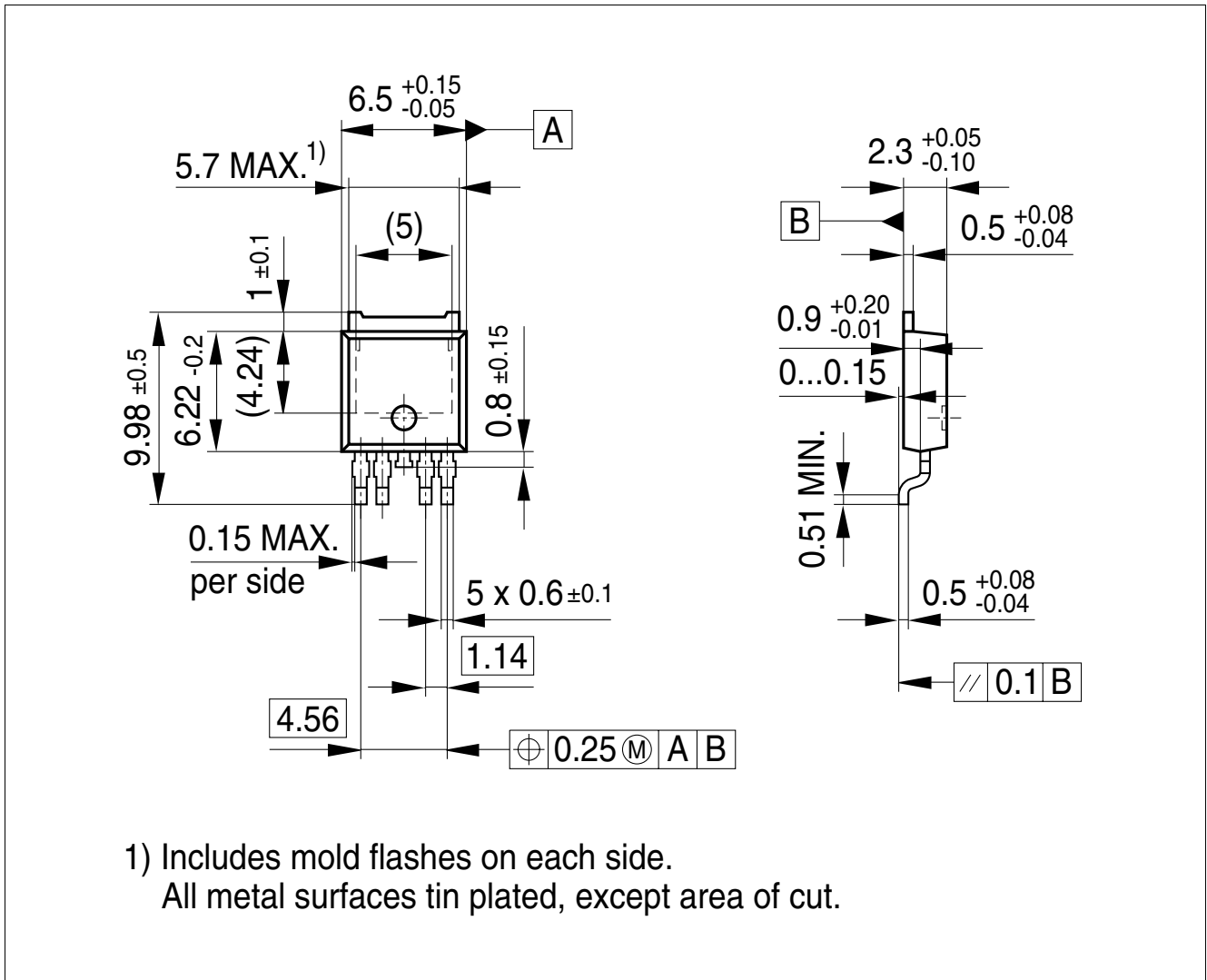


Figure 5 PG-TO252-5

**Green Product (RoHS compliant)**

To meet the world-wide customer requirements for environmentally friendly products and to be compliant with government regulations the device is available as a green product. Green products are RoHS-Compliant (i.e Pb-free finish on leads and suitable for Pb-free soldering according to IPC/JEDEC J-STD-020).

For further information on alternative packages, please visit our website:  
<http://www.infineon.com/packages>.

Dimensions in mm

## 7 Revision History

Revision	Date	Changes
1.0	2009-06-01	initial version data sheet

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